S	earci	n Notes	5

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/047,467	XU ET AL.	
Examiner	Art Unit	
Hong Cho	2616	

SEARCHED			
Class	Subclass	Date	Examiner
370	235, 236, 412-418, 468	11/7/2006	нс
		-	
	-		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	236	11/7/2006	нс
	414	11/7/2006	НС
	468	11/7/2006	нс
see interference search history printout		11/8/2006	нс

SEARCH NOT)
	DATE	EXMR
370/235, 236, 412-418, 468 (see search history printout)	11/7/2006	нс
consulted Chau Nguyen for search help	11/7/2006	НС
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